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 Application/Control No.	Applicant(s)/Patent under Reexamination
10/076,578	LUCIANO, FRANK JOHN
Examiner	- Art Unit
Bob A. Phunkulh	2616

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SEARCHED			
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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See atta	achment	12/7/2006	BAP	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
370/352, 353, 356 (text search)	12/13/2005	ВАР
370/352, 353, 354, 355 (text search)	8/8/2006	ВАР
370/352, 356, 401 (text search - updated)	12/7/2006	ВАР
379/88.17, 93.01 (text search)	12/7/2006	ВАР
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